Sèarch Notes

Applicant(s)/Patent under Reexamination

10/797,796 Examiner

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Art Unit

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3711

SEARCHED					
Class	Subclass	Date	Examiner		
473	378-385	10/5/2007	RT		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
see EAST search	10/5/2007	RT		